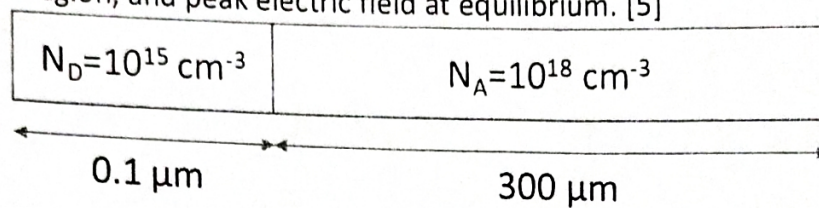


Use the following semiconductor parameters unless specified otherwise:

Bandgap	1.12 eV	Diffusion length	$L_n = 50 \mu\text{m}$ $L_p = 30 \mu\text{m}$
Effective DOS at 300 K	$N_c = 2.8 \times 10^{19} \text{ cm}^{-3}$ $N_v = 3.1 \times 10^{19} \text{ cm}^{-3}$	Mobility	$\mu_n = 300 \times (T/300)^{-3/2}$ $\mu_p = 100 \times (T/300)^{-3/2}$
Temperature	300 K	Free space dielectric constant	$\epsilon_0 = 8.85 \times 10^{-14} \text{ F/cm}$

1. Consider a diode with the above material parameters. Find out the built-in potential, width of the depletion region, and peak electric field at equilibrium. [5]



2. Consider a long Silicon diode with $N_D = N_A = 10^{17} \text{ cm}^{-3}$. Find out the position the quasi Fermi levels for electrons and holes at both the edges the of depletion regions with respect of to the valence band. [5]
3. Consider the above semiconductor to be direct bandgap. A piece of this semiconductor is uniformly illuminated with an optical generation rate of $10^{14} \text{ cm}^{-3}/\text{sec}$. Find out the excess current flowing through the semiconductor due to the optical generation at 1 V when the length of the semiconductor is $1 \mu\text{m}$. [5]
4. Consider the diode in question 2. Find out the current at room temperature for forward bias 0.4 V. What is the voltage we need to apply at 400 K to get the same current. Assume minority carrier lifetime does not change with temperature. [5]